

Search Notes

Application/Control No.

10/829,049

Examiner

Randall Chin

Applicant(s)/Patent under
Reexamination

OKANO ET AL.

Art Unit

1744

SEARCHED

Class	Subclass	Date	Examiner
15	256.5		
15	256.51		
101	425	10/13/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search	10/13/2006	RC